

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/695,485 PAIK ET AL.	
		Examiner	Art Unit	Page 1 of 1 Rodney G. McDonald 1753

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,800,177	10-2004	Shin et al.	204/192.16
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	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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